

Author Index to Volume 107

Numbers in parenthesis in italic type after the volume number are the issue numbers

- No. 1 January–February
- No. 2 March–April
- No. 3 May–June
- No. 4 July–August
- No. 5 September–October
- No. 6 November–December

A

Abassi, F.

Quantitating Fluorescence Intensity From Fluorophores: Practical Use of MESF Values. Wang, L., Gaigalas, A. K., Abassi, F., Marti, G. E., Vogt, R. F., Schwarz, A., **107**(4), 339 (2002).

Ali, M. A.

Electron-Impact Total Ionization Cross Sections of Hydrocarbon Ions. Irikura, K. K., Kim, Y.-K., Ali, M. A., **107**(1), 63 (2002).

am Ende, B. A.

Accelerating Scientific Discovery Through Computation and Visualization II. Sims, J. S., George, W. L., Satterfield, S. G., Hung, H. K., Hagedorn, J. G., Ketcham, P. M., Griffin, T. J., Hagstrom, S. A., Franiatte, J. C., Bryant, G. W., Jaskólski, W., Martys, N. S., Bouldin, C. E., Simmons, V., Nicolas, O. P., Warren, J. A., am Ende, B. A., Koontz, J. E., Filla, B. J., Pourprix, V. G., Copley, S. R., Bohn, R. B., Peskin, A. P., Parker, Y. M., Devaney, J. E., **107**(3), 223 (2002).

Anderson, W. H. C.

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Arp, U.

Influence of the Vertical Emittance on the Calculability of the Synchrotron Ultraviolet Radiation Facility. Arp, U., **107**(5), 419 (2002).

B

Baruchel, J.

The Visible Cement Data Set. Bentz, D. P., Mizell, S., Satterfield, S., Devaney, J., George, W., Ketcham, P., Graham, J., Porterfield, J., Quenard, D., Vallee, F., Sallee, H., Boller, E., Baruchel, J., **107**(2), 137 (2002).

Beaubien, A.

The 1997 North American Interagency Intercomparison of Ultraviolet Spectroradiometers Including Narrowband Filter Radiometers. Lantz, K., Disterhoft, P., Early, E., Thompson, A., DeLuisi, J., Berndt, J., Harrison, L., Kiedron, P., Ehramjian, J., Bernhard, G., Cabasug, L., Robertson, J., Mou, W., Taylor, T., Slusser, J., Bigelow, D., Durham, B., Janson, G., Hayes, D., Beaubien, M., Beaubien, A., **107**(1), 19 (2002).

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Benner, B. A., Jr.

A Critical Evaluation of Interlaboratory Data on Total, Elemental, and Isotopic Carbon in the Carbonaceous Particle Reference Material, NIST SRM 1649a. Currie, L. A., Benner, B. A., Jr., Kessler, J. D., Klinedinst, D. B., Klouda, G. A., Marolf, J. V., Slater, J. F., Wise, S. A., Cachier, H., Cary, R., Chow, J. C., Watson, J., Druffel, E. R. M.,

Masiello, C. A., Eglinton, T. I., Pearson, A., Reddy, C. M., Gustafsson, Ö., Quinn, J. G., Hartmann, P. C., Hedges, J. I., Prentice, K. M., Kirchstetter, T. W., Novakov, T., Puxbaum, H., Schmid, H., **107(3)**, 279 (2002).

Bennett, H. S.

A Systematic Approach for Multidimensional, Closed-Form Analytic Modeling: Effective Intrinsic Carrier Concentrations in $\text{Ga}_{1-x}\text{Al}_x\text{As}$ Heterostructures. Bennett, H. S., Filliben, J. J., **107(1)**, 69 (2002).

Bentz, D. P.

The Visible Cement Data Set. Bentz, D. P., Mizell, S., Satterfield, S., Devaney, J., George, W., Ketcham, P., Graham, J., Porterfield, J., Quenard, D., Vallee, F., Sallee, H., Boller, E., Baruchel, J., **107(2)**, 137 (2002).

Berndt, J.

The 1997 North American Interagency Intercomparison of Ultraviolet Spectroradiometers Including Narrowband Filter Radiometers. Lantz, K., Disterhoft, P., Early, E., Thompson, A., DeLuisi, J., Berndt, J., Harrison, L., Kiedron, P., Ehramjian, J., Bernhard, G., Cabasug, L., Robertson, J., Mou, W., Taylor, T., Slusser, J., Bigelow, D., Durham, B., Janson, G., Hayes, D., Beaubien, M., Beaubien, A., **107(1)**, 19 (2002).

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Boatner, L. A.

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Bohn, R. B.

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Boller, E.

The Visible Cement Data Set. Bentz, D. P., Mizell, S., Satterfield, S., Devaney, J., George, W., Ketcham, P., Graham, J., Porterfield, J., Quenard, D., Vallee, F., Sallee, H., Boller, E., Baruchel, J., **107(2)**, 137 (2002).

Bouldin, C. E.

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Brault, J. W.

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Bright, D. S.

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Brown, S. W.

Development of a Tunable LED-Based Colorimetric Source. Brown, S. W., Santana, C., Eppeldauer, G. P., **107(4)**, 363 (2002).

Bryant, G. W.

Accelerating Scientific Discovery Through Computation and Visualization II. Sims, J. S., George, W. L., Satterfield, S. G., Hung, H. K., Hagedorn, J. G., Ketcham, P. M., Griffin, T. J., Hagstrom, S. A., Franiatte, J. C., Bryant, G. W., Jaskólski, W., Martys, N. S., Bouldin, C. E., Simmons, V., Nicolas, O. P., Warren, J. A., am Ende, B. A., Koontz, J. E., Filla, B. J., Pourprix, V. G., Copley, S. R., Bohn, R. B., Peskin, A. P., Parker, Y. M., Devaney, J. E., **107(3)**, 223 (2002).

C

Cabasug, L.

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Cachier, H.

A Critical Evaluation of Interlaboratory Data on Total, Elemental, and Isotopic Carbon in the Carbonaceous Particle Reference Material, NIST SRM 1649a. Currie, L. A., Benner, B. A., Jr., Kessler, J. D., Klinedinst, D. B., Klouda, G. A., Marolf, J. V., Slater, J. F., Wise, S. A., Cachier, H., Cary, R., Chow, J. C., Watson, J., Druffel, E. R. M., Masiello, C. A., Eglinton, T. I., Pearson, A., Reddy, C. M., Gustafsson, Ö., Quinn, J. G., Hartmann, P. C., Hedges, J. I., Prentice, K. M., Kirchstetter, T. W., Novakov, T., Puxbaum, H., Schmid, H., **107(3)**, 279 (2002).

Carle, M. T.

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Carlson, B. C.

Three Improvements in Reduction and Computation of Elliptic Integrals. Carlson, B. C., **107(5)**, 413 (2002).

Carlton, R. A.

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Carpenter, P.

Characterization of Corning EPMA Standard Glasses 95IRV, 95IRW, and 95IRX. Carpenter, P., Counce, D., Kluk, E., Nabelek, C., **107(6)**, 703 (2002).

Cary, R.

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Chow, J. C.

A Critical Evaluation of Interlaboratory Data on Total, Elemental, and Isotopic Carbon in the Carbonaceous Particle Reference Material, NIST SRM 1649a. Currie, L. A., Benner, B. A., Jr., Kessler, J. D., Klinedinst, D. B., Klouda, G. A., Marolf, J. V., Slater, J. F., Wise, S. A., Cachier, H., Cary, R., Chow, J. C., Watson, J., Druffel, E. R. M., Masiello, C. A., Eglinton, T. I., Pearson, A., Reddy, C. M., Gustafsson, Ö., Quinn, J. G., Hartmann, P. C., Hedges, J. I., Prentice, K. M., Kirchstetter, T. W., Novakov, T., Puxbaum, H., Schmid, H., **107(3)**, 279 (2002).

Copley, S. R.

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Warren, J. A., am Ende, B. A., Koontz, J. E., Filla, B. J., Pourprix, V. G., Copley, S. R., Bohn, R. B., Peskin, A. P., Parker, Y. M., Devaney, J. E., **107(3)**, 223 (2002).

Counce, D.

Characterization of Corning EPMA Standard Glasses 95IRV, 95IRW, and 95IRX. Carpenter, P., Counce, D., Kluk, E., Nabelek, C., **107(6)**, 703 (2002).

Currie, L. A.

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D

DeLuisi, J.

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Devaney, J. E.

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The Visible Cement Data Set. Bentz, D. P., Mizell, S., Satterfield, S., Devaney, J., George, W., Ketcham, P., Graham, J., Porterfield, J., Quenard, D., Vallee, F., Sallee, H., Boller, E., Baruchel, J., **107(2)**, 137 (2002).

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Donovan, J. J.

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Druffel, E. R. M.

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Durham, B.

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E

Early, E.

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Eggins, S.

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Eitzen, D. G.

Transient Green's Tensor for a Layered Solid Half-Space With Different Interface Conditions. Ren, S.-C., Hsu, N. N., Eitzen, D. G., **107(5)**, 445 (2002).

Engle, P. D.

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Eppeldauer, G. P.

Development of a Tunable LED-Based Colorimetric Source. Brown, S. W., Santana, C., Eppeldauer, G. P., **107(4)**, 363 (2002).

F

Fialin, M.

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Filla, B. J.

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Franiatte, J. C.

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G

Gaigalas, A.

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Geller, J. D.

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George, W. L.

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The Visible Cement Data Set. Bentz, D. P., Mizell, S., Satterfield, S., Devaney, J., George, W., Ketcham, P., Graham, J., Porterfield, J., Quenard, D., Vallee, F., Sallee, H., Boller, E., Baruchel, J., **107(2)**, 137 (2002).

Gillen, G.

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Graham, J.

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Griffin, T. J.

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